

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S4	993	Byoung-\$.in.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:20
S6	9353	(substrate or wafer) same defect\$3 same detect\$3	US-PGPUB; USPAT	ADJ	ON	2007/05/23 13:51
S7	5841	S6 and (difference or differential)	US-PGPUB; USPAT	ADJ	ON	2007/05/23 13:51
S8	601	S7 and "382".clas.	US-PGPUB; USPAT	ADJ	ON	2007/05/23 13:52
S9	411	S8 and reflect\$3	US-PGPUB; USPAT	ADJ	ON	2007/05/23 16:02
S10	12	("4702606" "4742376" "4805123" "5659172" "5792580" "5793887" "5808735" "5923403" "6097473" "6333992" "6614923" "6700667").PN.	US-PGPUB; USPAT; USOCR	ADJ	ON	2007/05/23 14:06
S11	1	"7020350".pn.	US-PGPUB; USPAT; USOCR	ADJ	ON	2007/05/23 14:06
S12	106	S9 and (defect near2 (reference or template))	US-PGPUB; USPAT	ADJ	ON	2007/05/23 16:59
S13	2	("4736437" "6292582").PN.	US-PGPUB; USPAT; USOCR	ADJ	ON	2007/05/23 16:08
S14	1	S9 and (defect near2 (reference or template) near10 similar\$3)	US-PGPUB; USPAT	ADJ	ON	2007/05/23 17:00
S15	13	S9 and (defect near2 (reference or template) same similar\$3)	US-PGPUB; USPAT	ADJ	ON	2007/05/23 17:01
S16	6	("5475766" "5619429" "5965306" "6016357" "6171731" "6223139").PN.	US-PGPUB; USPAT; USOCR	ADJ	ON	2007/05/23 17:19
S17	1	"5737072".pn.	US-PGPUB; USPAT; USOCR	ADJ	ON	2007/05/23 17:19
S18	1	"10/754013".app.	US-PGPUB; USPAT	ADJ	ON	2007/05/23 18:42
S19	98	S9 and (UV or U\$V or (ultra\$violet))	US-PGPUB; USPAT	ADJ	ON	2007/05/23 18:43
S20	5	(10/442955 10/749670 10/754013 11/198314).app.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:09
S21	14	(09/265840 09/384885 09/940943 10/309166 10/393015 10/442955 1 0/749670 10/754013 10/801525 10 /822055).app.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:10

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S22	497	382/144.ccls.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:14
S23	132	S22 and (substrate or wafer) same defect\$3 same detect\$3	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:14
S24	783	382/145.ccls.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:15
S25	930	382/147-150.ccls.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:15
S26	419	S24 and reflect\$3	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:16
S27	9371	(substrate or wafer) same defect\$3 same detect\$3	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:16
S28	5852	S27 and (difference or differential)	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:16
S29	601	S28 and "382".clas.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:16
S30	411	S29 and reflect\$3	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:16
S31	113	S26 and S30	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:16
S32	1	("5153444").PN.	US-PGPUB; USPAT	ADJ	ON	2007/05/24 17:21